### RESISTANCE HITESTER RM3543

**BSC** 

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# **Resistance Meter for Ultra-low and Low Shunt Resistance**

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2.0000mB

1.000%

+ 1.000 % STAT

HIOKI RM3543 D1 HEBISTANCE HITESTER

REF

lipp

LOW

INTI 10mg | FAST | DADJ OVC SC)

0.000 %

12.00000 mg

# Measuring 0.1 m $\Omega$ with a High Accuracy of ±0.16% and High Resolution of 0.01 $\mu\Omega^*$

The RM3543 and RM3543-01 Resistance HiTESTERs can measure DC resistance such as a low shunt resistance with high speed and high accuracy using the DC four-terminal method. Shunt resistance of 0.1 m $\Omega$  can be measured with an accuracy of ±1%. The resistance meters provide advanced contact-check, comparator, and data export functions. In addition, its intuitive user interface and strong noise immunity are suitable for use in automated systems.





8715 Mesa Point Terrace San Diego, CA 92154 Toll Free: 1.866.363.6634 Tel: 1.619.429.4545 Fax: 1.619.374.7012 Email: sales@calright.com http://www.calright.com

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## Shunt Resistance Meters Capable of Measuring 0.1 m $\Omega$

**RESISTANCE HITESTER RM3543, RM3543-01** 

### Features

- Measure 0.1 mΩ with a high accuracy of ±0.16%
- Superb repeatable measurement accuracy
- User-friendly operability

#### Ultra-accurate and high-resolution resistance meter ideal for incorporation in automated systems.

10 10 mm

#### Advanced Enough to Measure 0.1 mΩ ±1% Shunts with Room to Spare

10000

The shunt resistance meters provide higher efficiency and accuracy. Using the AVERAGE function,  $0.1m\Omega\pm\!1\%$  shunts can be measured at a high  $\pm0.16\%$  accuracy and high resolution of  $0.01~\mu\Omega$ 



#### Scaling Function Corrects Differences to Simulate Testing Component Mounted on Board

The scaling function can correct the differences in the measurement resistance values between the component alone and the component mounted on the board. The function is useful in testing a current detection resistor for low resistances such as a shunt resistance.



#### OVC (Offset Voltage Compensation)

Thermal EMF occurs at the contact point of different metals. This voltage affects measurements, and if large enough, can cause measurement errors. The offset voltage compensation function minimizes the effect of thermal EMF to maintain measurement accuracy. Particularly when measuring shunt resistances and low resistances where the detection voltage is small, OVC is essential to maintain accuracy.

#### Maximum Measurement Current of 1 A and Pulse Application Function Reduce Heat Generation of Samples

A pulse application function that applies current only during measurement reduces heat generation that may cause unstable resistance measurement values. In addition, the maximum measurement current of 1 A, a thermal electromotive force cancellation function, and an ultra-low noise measurement circuit minimize the variation in the measurement values.

#### Easy Setup Using Numerical Keypad

The user-friendly interface features a high-contrast graphic LCD display, function keys and numerical keypad. Numbers can be input from the numerical keypad easily and speedily to configure the settings for the comparator.



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## **Contact Improver and Check Functions**

### **2.** Positive contact assures reliable measurements

Select contact-check and make other adjustments to ensure accurate measurement and the best performance.

Configuration Screen (MISC)

TRG RANGE SPEED OF   INT 10mΩ FAST 0   10.01211mΩ   + 0.121%	DJCOMPLOCK MISC	RETURN
1001211.0	REF 10.0000mg	MEAS
+ 0121	UPP +1.000%	DATA SYSTEM
. 0.121%	-1.000%	oronen

Measurement Configuration Screen (MEAS)

Configure the settings for various types of contact-check and fine-tune the measurement timing.

0.0 ms 0.0 ms 0FF A:1,00000 B:+0,0000 c:10mΩ B:+0,0000 20 ms	) )OmΩ	RANGE	~	+ RETU	RN		
0FF A:1.00000 B:+0.0000 C:10mΩ B:+0.0000 2.0 ms	OmΩ	NUM	~		RN		
A:1.00000 B:+0.0000 : 10mΩ B:+0.0000 2.0 ms	OmΩ	NUM	~		RN		
B:+0.0000 :10mΩ B:+0.0000 2.0 ms	OmΩ	NUM	~		RN		
::10mΩ B:+0.0000 2.0 ms		NUM	^		RN		
B:+0.0000 2.0 ms	)OmΩ	NUM	^		RN		
2.0 ms	ΩmO						
				ns			
5.0 ms			F	LC			
1PLC			1		-		
ON	16T i	mes	٧L		-		
::10mΩ			F	ETH	DN		
ON	16T i	mes	~ F		NI1		
ON	1000	-	10	IFF			
ON	35mA	÷ –					
ON	NORM	AL -	-				
	1PLC ON : 10mΩ ON ON ON	1PLC ON 16Ti ::10mΩ ON 16Ti ON 16Ti ON 100Ω ON 35mA ON 35mA	IPLC 16Times   ON 16Times   ON 16Times   ON 16Times   ON 16Times   ON 36TA   ON 35mA   ON NORMAL	IPLC 16Times    ON 16Times    ::10mΩ 0N 16Times    ON 16Times     ON 16Times     ON 16Times     ON 16Times     ON 100Ω     ON 35mA	IPLC IGT imes    ON 16T imes    ::10mΩ RETU OF   ON 16T imes OF   ON 16T imes OF   ON 16T imes OF   ON 100Ω OF   ON 35mA OF   ON NORMAL OF	IPLC IET imes RETURN   ON 16T imes RETURN   ON 16T imes RETURN   ON 16T imes Northal   ON 15T imes Northal   ON 15T imes Northal   ON 35mA Control   ON 35mA Control	IPLC IPLC   ON 16Times   : 10mΩ RETURN   ON 16Times   ON 16Times   ON 16Times   ON 16Times   ON 16Times   ON 100Ω   ON 35mA   ON 35mA

#### Always-On Contact Checking

High-speed, reliable measurements are achieved by performing contact checks while measuring (instead of before and after, as done until now).

#### Contact Improver Function Makes Reliable Contacts Quickly

The "Contact Improver" function improves bad contacts between probes and test samples. Contacts errors are reduced by penetrating oxidation and impurities between probes and samples.

Reducing contact errors can increase productivity and quality. The intensity of the Contact Improver function can be adjusted to suit the probe type.

#### Voltage Monitor Function Monitors Contact Condition Changes

The Voltage Monitor function detects large voltage fluctuations due to changes in current terminal contact resistance or noise from mechanical vibrations as contact errors. This increases the reliability of the measured values.

#### Probe Short-Circuit Detection Function Ensures Reliable Four-Terminal Measurements

A conductive foreign object between the POT and CUR probe tips inhibits reliable four-terminal measurements. Shortcircuited probe anomalies are detected by checking the resistance between these tips when not measuring.



## **3.** Speed and functions required for automated systems have been achieved

#### Strong Noise Immunity Meeting the IEC Standard Requirements Ensures Stable Operation in an Industrial Noise Environment

The noise immunity meets the requirements for the IEC61326, 61000-3-2, and 61000-3-3 standards. Even if noise is generated by the on-off operation of a large inductor nearby, the impact on the measurement values is minimized.

#### Settings Monitor Function Minimizes Risk of Human Error

When using two instruments, a difference in settings disables TRIG input and causes a warning notification.

This function eliminates setting mistakes caused by human error.



#### High-speed Data Export and Data Memory Functions

High-speed processing of measured values enables high-speed export to the external interfaces. (RS-232C: 2 ms and GP-IB: 1 ms) Furthermore, the memory function to store 30,000 records enables batch transfer. Statistical calculation and data printing functions useful for production control are also available.

#### Measurement Times \*1,\*2

Values in parenthesis are for 50 Hz (where timing depends on line frequency), units are in milliseconds

Range	Measurement Speed				
naliye	FAST	MED	SLOW		
10mΩ	11	17	40 (47)		
100mΩ (1A)	5.0	13	36 (43)		
100mΩ (100mA)	3.8	13	36 (43)		
1000mΩ	2.0	6.4	35 (41)		
10Ω	1.6	6.0	34 (41)		
100Ω	1.6	4.0	34 (41)		
1000Ω	1.6	4.0	34 (41)		
T-1					

Tolerance:  $\pm 10\% \pm 0.2$  ms

\*1. Under default settings except those specified, without retries. \*2. The measurement time for the average n times is obtained by multiply-

2. The measurement time for the average in times is obtained by intuitiplying the above measurement time by a factor of n. Example: The measurement time for the 10 m $\Omega$  range, SLOW, and the

Example: The measurement time for the 10 m  $\Omega$  range, SLOW, and the average 16 times is 640 (752) ms.



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#### RM3543 Measurement Accuracy

Conditions of Guaranteed Accuracy (Accuracy guaranteed for 1 year, Post-adjustment accuracy guaranteed for 1 year)

● After 30-minute warm-up time. ● Add ±(0.1% measurement accuracy)/°C to the accuracy specifications below between 0 and 18°C, and between 28 and 40°C • Temperature variation after self-calibration must be within  $\pm 2^{\circ}$ C.

#### Resistance Measurement [1-year accuracy (@23 ±5°C, 80% RH or less)]

Accuracy =  $\pm$ (% rdg. + % f.s.)

 $(f_s = calculated 1\,000\,000 \,dgt \text{ where } 0\,001\% \,f_s = 10 \,dgt)$ 

Example. 0.015 + 0.008 ..... 0.015% rdg. + 0.008% f.s.

(i.s. – calculated 1,000,000 dgl., where 0.001% i.s. – 10 dgl.)								
Range	Maximum display value <sup>*1</sup>	Resolution	FAST	MEDIUM	SLOW	Measurement current <sup>*2</sup>	OVC	Open-Circuit voltage
10mΩ (Average 16 times <sup>*3</sup> )	12.00000mΩ	10nΩ	0.060+0.005	0.060+0.003	0.060+0.001 <sup>°3</sup>	1A	ON	
10mΩ					0.060+0.002			
100mΩ(1A)	$120.0000m\Omega$	100nΩ	0.060+0.003	0.060+0.002	0.060+0.001	1A	ON	
$100m\Omega(100mA)$	120.0000mΩ	100nΩ	$0.015 \pm 0.008$	0.015+0.003	0.015+0.002	100mA	ON	20Vmax*4,*5
1000mΩ	1200.000mΩ	1μΩ	0.012+0.003	0.012+0.002	0.012+0.001	100mA	ON	
10Ω	12.00000Ω	10μΩ	0.010+0.003	0.008 + 0.002	0.008+0.001	10mA	ON	
100Ω	120.0000Ω	100μΩ	0.009+0.003	0.007+0.002	0.007+0.001	10mA	ON	
1000Ω	1200.000Ω	lmΩ	0.008+0.003	0.006+0.002	0.006+0.001	1mA	ON	

\*1. Negative values can be up to 10% of positive full scale. \*2. Measurement current precision is ±5%.

\*3. When the average ON 16 times or more is set (SLOW is specified only for the 10 mΩ range, other specifications not dependent on AVERAGE setting.)

\*4. Voltage when not measuring is 20 mV or less, with current mode set at PULSE and Contact Improver Setting set at OFF/PULSE (measured with a voltmeter having 10 MΩ). \*5. With the sum of resistances of the cables, sample, and contacts less than (open-circuit voltage) / (measurement current).

Example: 1 A measurement current can be used when the sum of resistances of the cables, sample, and contacts is no more than 2  $\Omega$ .

#### RM3543 Specifications

Measurement types	Resistance: $0.00000 \text{ m}\Omega (10 \text{ m}\Omega \text{ range}) \text{ to } 1200.000 \Omega$	Measurement fault detection functions	Out-of-range detection, contact check, current monitor, voltage monitor		
Measurement method	Four-terminal, constant-current DC	Memory storage	30,000 values (volatile memory, no backup)		
Range switching	Measurement terminals: 22-mm BNC female jacks Comparator on: Auto-range setting according to com- parator reference or upper threshold setting.	Interfaces	EXT I/O, RS-232C, Printer, Settings Monitor Functional terminals (SET MONITOR) GP-IB (Model RM3543-01)		
	Comparator off: Manual range setting	RS-232C bit rates	9,600, 19,200, or 38,400 bps		
Zero-Adjustment	Range: -1 to 10 $\Omega$ (wiring resistance compensation for two-terminal measurements)	RM3543 General Specifications			
Trigger	Internal or External		0°C (32°F) to 40°C (104°F),		
Sampling	Fast, Medium, and Slow	and humidity	80% RH or less (non-condensating)		
Integration time setting function <sup>'1</sup>	0.1 to 100.0 ms, PLC <sup>*2</sup> setting available 1 to 5 PLC @ 50 Hz, 1 to 6 PLC @60 Hz *2. One PLC = one power line cycle (mains waveform	Storage temperature and humidity	10°C (50°F) to 50°C (122°F), 80% RH or less (non-condensating)		
		Operating environment	Indoors, Pollution Degree 2, up to 2,000 m (6,562 ft) ASL		
	period)	Rated mains supply voltage	100 to 240 V AC ±10%		
	DELAY1 = Set to allow for mechanical delay of trigger	Rated mains supply frequency	50 / 60 Hz		
	input and probing (affects all ranges), from 0.0 to 100.0	Power consumption	40 VA		
Delay	ms DELAY2' <sup>1</sup> = Set to allow for measurement object re- sponse (each range independently), from 0.0 to 100.0 ms	Insulation withstand potential	1.62 kV AC for 15s, with 10 mA cutoff current Between all mains supply terminals and protective ground, interfaces, and measurement jacks		
Functions	Self-calibration, probe short-circuit detection, Contact Improver, current mode setting, OVC (offset voltage compensation), settings monitor, retry, average (OFF, 2	Dimensions	Approx. 260 mm (10.24 in) W $\times$ 88 mm (3.46 in) H $\times$ 300 mm (11.81 in) D (without projections)		
	to 32 times), scaling, statistical calculations, key-lock,	Mass	Approx. 3.0 kg (105.8 oz)		
	comparator (relative tolerance or absolute range modes), EOM pulse width setting, data export, binary data out-	Accessories	Power cord $\times 1$ , EXT I/O male connector $\times 1$ , Operation manual $\times 1$ , Operation guide $\times 1$		
	put, auto-memory *1. Settable for each range independently	Applicable Standards	Safety: EN61010 EMC: EN61326, EN61000-3-2, EN61000-3-3		

#### Ordering information

Model : RE	SISTANCE HITESTER RM3543
Model No. (Order Code)	(Note)
RM3543	
RM3543-01	(Built in GP-IB interface)

RM3543-01 Test fixtures are not supplied with the unit. Select an optional test fixture when ordering.

#### Optional accessories

4-TERMINAL PROBE 9140 (1 m (3.28 ft)) TEST FIXTURE 9262 (direct connection type) SMD TEST FIXTURE 9263 (direct connection type) 4-TERMINAL PROBE 9500 (1 m (3.28 ft)) GP-IB CONNECTION CABLE 9151-02 (2 m (6.56 ft)) RS-232C CABLE 9637 (9-pin to 9-pin crossed cable / 1.8 m (5.91 ft)) RS-232C CABLE 9638 (9-pin to 25-pin crossed cable / 1.8 m (5.91 ft))

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